Vincotech

10-FZ12NMA080SH04-M260F13
10-PZ12NMA080SH04-M260F13Y
datasheet

*flow*MNPC 0	1200 V / 80 A

Features

- Three-level MNPC (T-Type)
- Reactive power capability
- Low inductance layout
- Improved LVRT

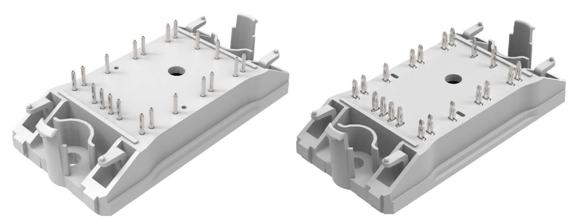
Target applications

- Industrial Drives
- Solar Inverters
- UPS

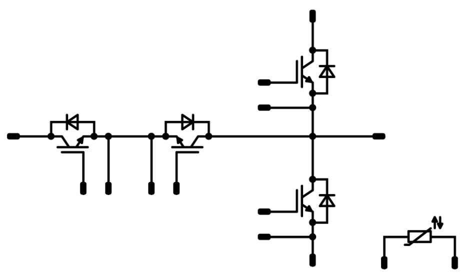
Types

- 10-FZ12NMA080SH04-M260F13
- 10-PZ12NMA080SH04-M260F13Y

flow 0 12mm housing



Schematic



Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Buck Switch				
Collector-emitter voltage	V_{CES}		1200	V
Collector current	I_C	$T_j = T_{jmax}$ T_s = 80 °C	76	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}	240	A
Turn off safe operating area		$T_j \le$ 175 °C, $V_{CE} \le$ 1200 V	320	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$ T_s = 80 °C	186	W
Gate-emitter voltage	V_{GES}		±20	V
Short circuit ratings	t_{SC}	V_{GE} = 15 V V_{cc} = 800 V T_j = 150 °C	10	μs
Maximum junction temperature	T_{jmax}		175	°C

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Condition		Value	Unit
Buck Diode					
Peak repetitive reverse voltage	V_{RRM}			650	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$	T_s = 80 °C	55	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}		150	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	71	W
Maximum junction temperature	T_{jmax}			175	°C
Boost Switch					
Collector-emitter voltage	V_{CES}			650	V
Collector current	I_C	$T_j = T_{jmax}$	T_s = 80 °C	58	A
Repetitive peak collector current	I_{CRM}	t_p limited by T_{jmax}		225	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	101	W
Gate-emitter voltage	V_{GES}			±20	V
Short circuit ratings	t_{SC}	V_{GE} = 15 V V_{cc} = 360 V	T_j = 150 °C	6	µs
Maximum junction temperature	T_{jmax}			175	°C
Boost Diode					
Peak repetitive reverse voltage	V_{RRM}			1200	V
Continuous (direct) forward current	I_F	$T_j = T_{jmax}$	T_s = 80 °C	53	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}		100	A
Total power dissipation	P_{tot}	$T_j = T_{jmax}$	T_s = 80 °C	90	W
Maximum junction temperature	T_{jmax}			175	°C

Maximum Ratings

T_j = 25 °C, unless otherwise specified

Parameter	Symbol	Condition		Value	Unit
Module Properties					
Thermal Properties					
Storage temperature	T_{stg}			-40…+125	°C
Operation temperature under switching condition	T_{jop}			-40…(T_{jmax} - 25)	°C
Isolation Properties					
Isolation voltage	V_{isol}	DC Test Voltage*	t_p = 2 s	6000	V
		AC Voltage	t_p = 1 min	2500	V
Creepage distance				min. 12,7	mm
Clearance		Solder pin / Press-fit pin		9,15 / 8,95	mm
Comparative Tracking Index	CTI			> 200	

*100 % tested in production

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Buck Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{GE} = V_{CE}$			0,003	25	5,3	5,8	6,3	V
Collector-emitter saturation voltage	V_{CEsat}		15		80	25 125 150	1,78	1,99 2,33 2,41	2,42	V
Collector-emitter cut-off current	I_{CES}		0	1200		25			10	µA
Gate-emitter leakage current	I_{GES}		20	0		25			240	nA
Internal gate resistance	r_g							none		Ω
Input capacitance	C_{ies}	f= 1 Mhz	0	25		25		4660		pF
Output capacitance	C_{oes}							300		
Reverse transfer capacitance	C_{res}							260		
Gate charge	Q_g		15	960	80	25		370		nC
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						0,51		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{gon} = 4 Ω R_{goff} = 4 Ω	±15	350	50	25 125		77 79		ns
Rise time	t_r					25 125		11 14		
Turn-off delay time	$t_{d(off)}$					25 125		180 242		
Fall time	t_f					25 125		48 76		
Turn-on energy (per pulse)	E_{on}	Q_{rFWD} = 2,1 µC Q_{rFWD} = 3,8 µC				25 125		0,524 0,980		mWs
Turn-off energy (per pulse)	E_{off}					25 125		1,31 2,28		

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Buck Diode										
Static										
Forward voltage	V_F				75	25 125 150		1,53 1,49 1,47	1,92	V
Reverse leakage current	I_R			650		25			3,8	µA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,34		K/W
Dynamic										
Peak recovery current	I_{RRM}	di/dt = 5245 A/µs di/dt = 3680 A/µs	±15	350	50	25 125		63 73		A
Reverse recovery time	t_{rr}					25 125		52 92		ns
Recovered charge	Q_r					25 125		2,06 3,80		µC
Reverse recovered energy	E_{rec}					25 125		0,473 0,845		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125		1198 852		A/µs

Characteristic Values

Parameter	Symbol	Conditions	V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_{F} [V]	I_{C} [A] I_{D} [A] I_{F} [A]	T_{j} [°C]	Value Min	Value Typ	Value Max	Unit
Boost Switch										
Static										
Gate-emitter threshold voltage	$V_{GE(th)}$	$V_{GE} = V_{CE}$			0,0012	25	5,1	5,8	6,4	V
Collector-emitter saturation voltage	V_{CEsat}		15		75	25 125 150	0,93	1,46 1,55 1,76	1,77	V
Collector-emitter cut-off current	I_{CES}		0	650		25			3,8	µA
Gate-emitter leakage current	I_{GES}		20	0		25			600	nA
Internal gate resistance	r_{g}							none		Ω
Input capacitance	C_{ies}	f = 1 Mhz	0	25		25		4620		pF
Output capacitance	C_{oes}							288		
Reverse transfer capacitance	C_{res}							137		
Gate charge	Q_{g}		15	480	75	25		470		nC
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						0,94		K/W
Dynamic										
Turn-on delay time	$t_{d(on)}$	R_{gon} = 4 Ω R_{goff} = 4 Ω	±15	350	56	25 125		84 85		ns
Rise time	t_{r}					25 125		11 12		
Turn-off delay time	$t_{d(off)}$					25 125		177 205		
Fall time	t_{f}					25 125		86 105		
Turn-on energy (per pulse)	E_{on}	Q_{rFWD} = 5,3 µC Q_{rFWD} = 8,2 µC				25 125		0,528 0,747		mWs
Turn-off energy (per pulse)	E_{off}					25 125		1,86 2,50		

Characteristic Values

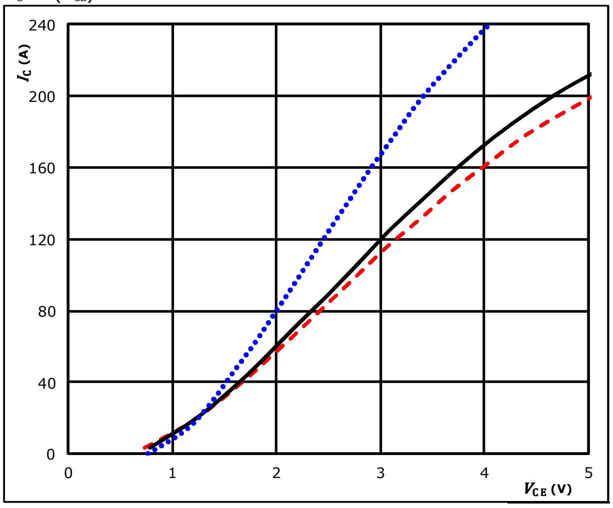
Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] V_{GS} [V]	V_{CE} [V] V_{DS} [V] V_F [V]	I_C [A] I_D [A] I_F [A]	T_j [°C]	Min	Typ	Max	
Boost Diode										
Static										
Forward voltage	V_F				50	25 125 150		1,73 1,70 1,68	2,05	V
Reverse leakage current	I_R			1200		25			10	µA
Thermal										
Thermal resistance junction to sink	$R_{th(j-s)}$	λ_{paste} = 3,4 W/mK (PSX)						1,06		K/W
Dynamic										
Peak recovery current	I_{RRM}	di/dt = 6090 A/µs di/dt = 5325 A/µs	±15	350	56	25 125		106 118		A
Reverse recovery time	t_{rr}					25 125		102 148		ns
Recovered charge	Q_r					25 125		5,32 8,22		µC
Reverse recovered energy	E_{rec}					25 125		1,55 2,42		mWs
Peak rate of fall of recovery current	$(di_{rf}/dt)_{max}$					25 125		6904 4951		A/µs
Thermistor										
Rated resistance	R					25		22		kΩ
Deviation of R_{100}	$\Delta_{R/R}$	R_{100} = 1486 Ω				100	-12		+14	%
Power dissipation	P					25		200		mW
Power dissipation constant						25		2		mW/K
B-value	$B_{(25/50)}$	Tol. ±3%				25		3950		K
B-value	$B_{(25/100)}$	Tol. ±3%				25		3998		K
Vincotech NTC Reference									B	

Buck Switch Characteristics

figure 1. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

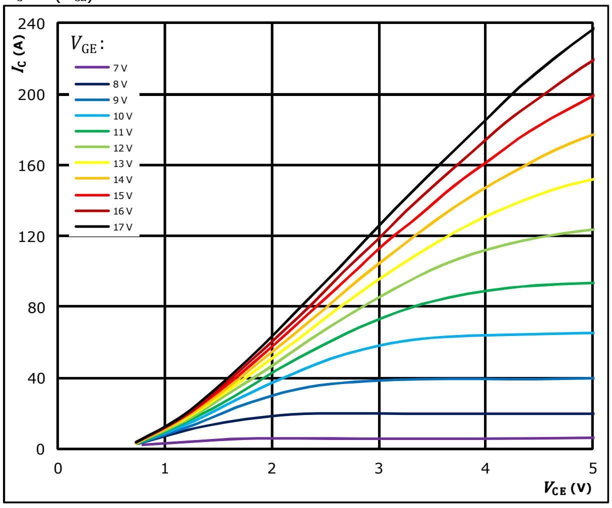


t_p =	250	µs		25 °C	dotted
V_{GE} =	15	V	T_j:	125 °C	solid
				150 °C	dashed

figure 2. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$



t_p = 250 µs

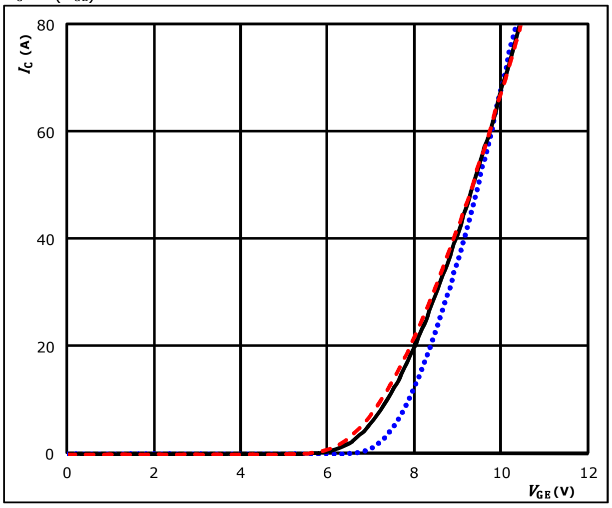
T_j = 150 °C

V_{GE} from 7 V to 17 V in steps of 1 V

figure 3. **IGBT**

Typical transfer characteristics

$I_C = f(V_{GE})$

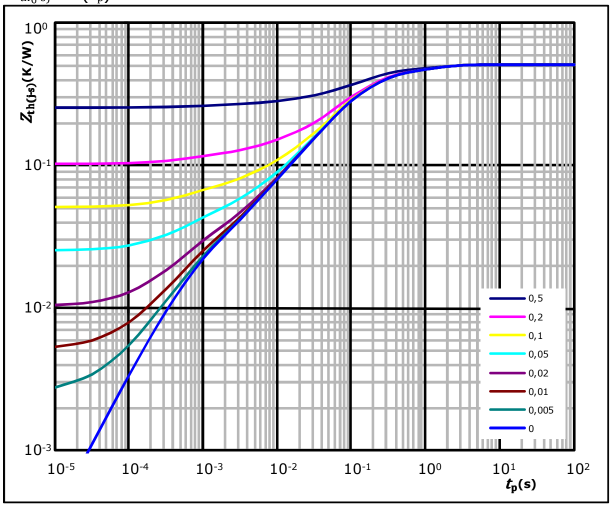


t_p =	100	µs		25 °C	dotted
V_{CE} =	10	V	T_j:	125 °C	solid
				150 °C	dashed

figure 4. **IGBT**

Transient thermal impedance as function of pulse duration

$Z_{th(j-s)} = f(t_p)$



D = t_p / T

$R_{th(j-s)}$ = 0,51 K/W

IGBT thermal model values

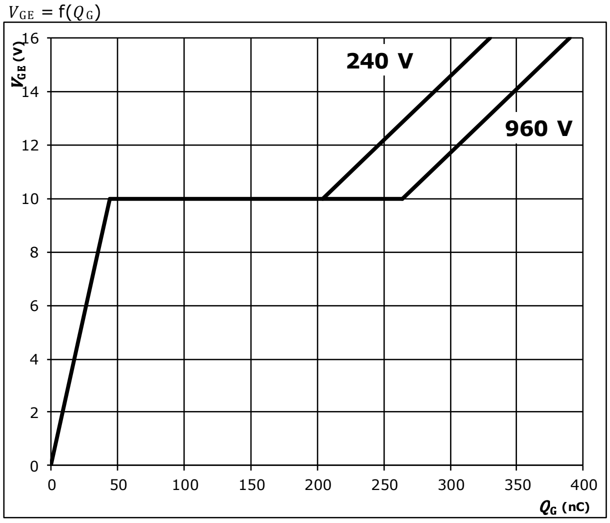
R (K/W)	τ (s)
9,51E-02	1,03E+00
1,84E-01	1,62E-01
1,81E-01	6,24E-02
3,37E-02	7,02E-03
1,79E-02	6,34E-04

Buck Switch Characteristics

figure 5. **IGBT**

Gate voltage vs gate charge

$V_{GE} = f(Q_G)$

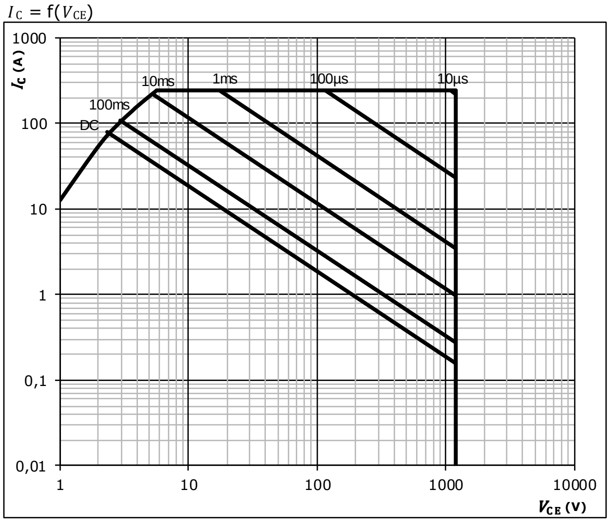


$I_C =$ 80 A

figure 6. **IGBT**

Safe operating area

$I_C = f(V_{CE})$

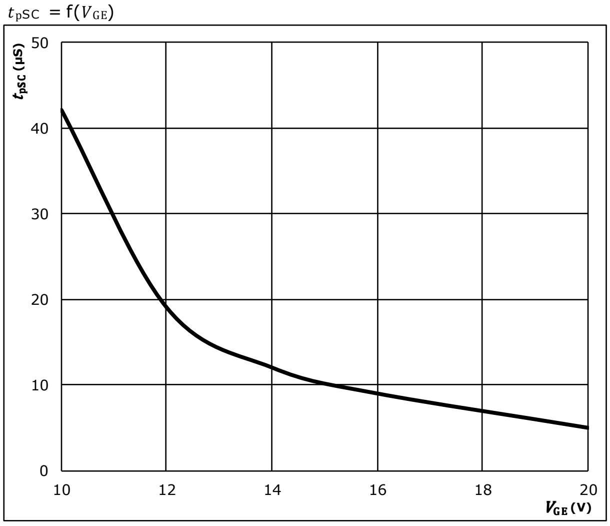


$D =$ single pulse
$T_s =$ 80 ºC
$V_{GE} =$ ±15 V
$T_j =$ T_{jmax}

figure 7. **IGBT**

Short circuit duration as a function of V_{GE}

$t_{pSC} = f(V_{GE})$

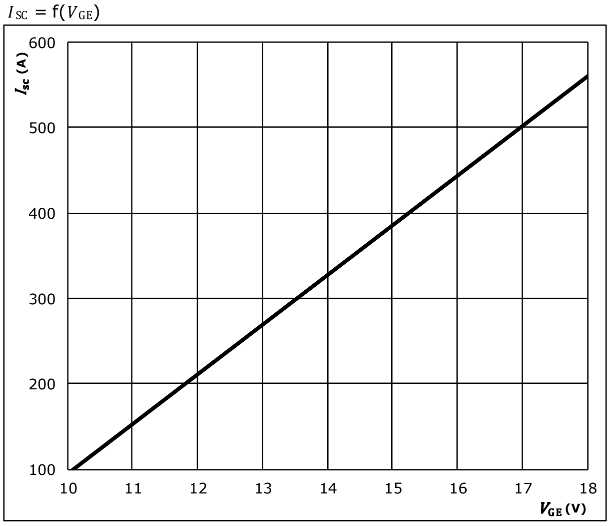


$V_{CE} =$ 600 V
$T_j \leq$ 150 ºC

figure 8. **IGBT**

Typical short circuit current as a function of V_{GE}

$I_{SC} = f(V_{GE})$



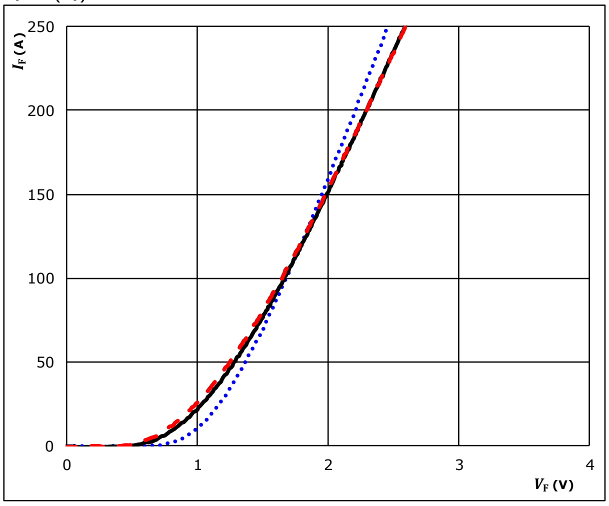
$V_{CE} \leq$ 600 V
$T_j \leq$ 25 ºC

Buck Diode Characteristics

figure 1.	FWD

Typical forward characteristics

$I_F = f(V_F)$



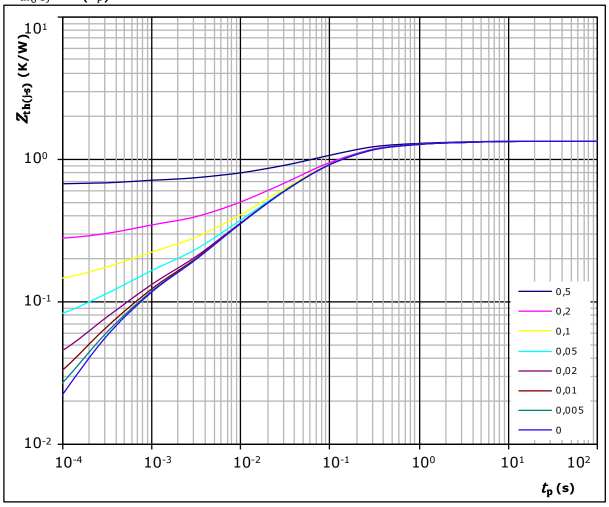
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 2.	FWD

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$

$R_{th(j-s)}$ = 1,34 K/W

FWD thermal model values

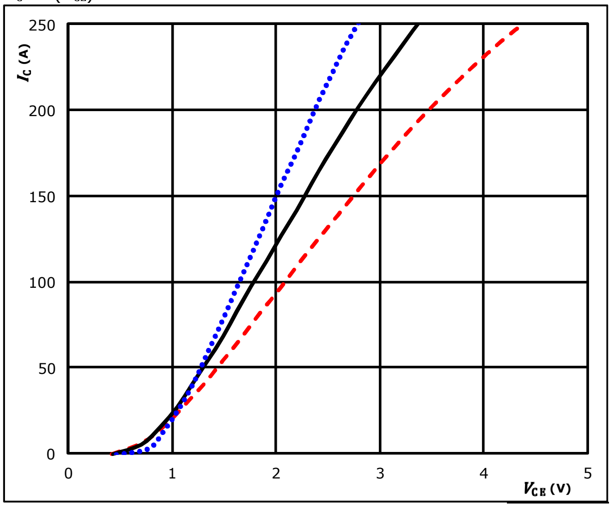
R (K/W)	τ (s)
5,84E-02	3,64E+00
1,57E-01	5,25E-01
5,86E-01	1,06E-01
3,27E-01	2,57E-02
1,27E-01	4,84E-03
8,12E-02	4,11E-04

Boost Switch Characteristics

figure 1. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

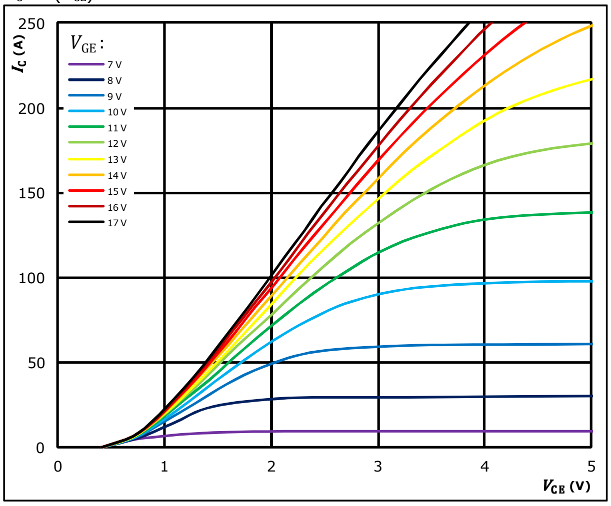


t_p = 250 μs
V_{GE} = 15 V
T_j: 25 °C, 125 °C, 150 °C

figure 2. **IGBT**

Typical output characteristics

$I_C = f(V_{CE})$

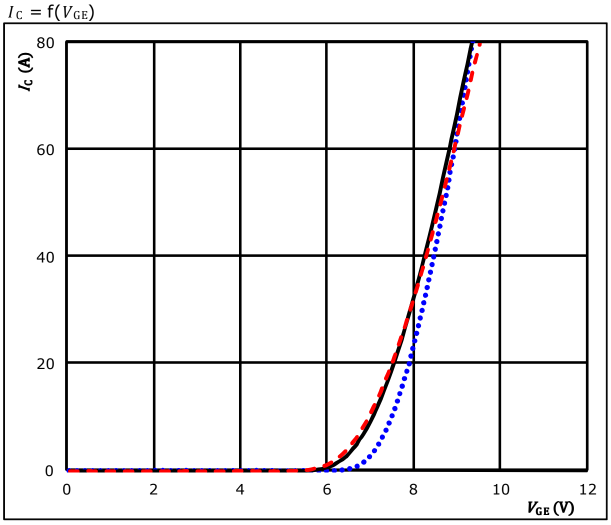


t_p = 250 μs
T_j = 150 °C
V_{GE} from 7 V to 17 V in steps of 1 V

figure 3. **IGBT**

Typical transfer characteristics

$I_C = f(V_{GE})$

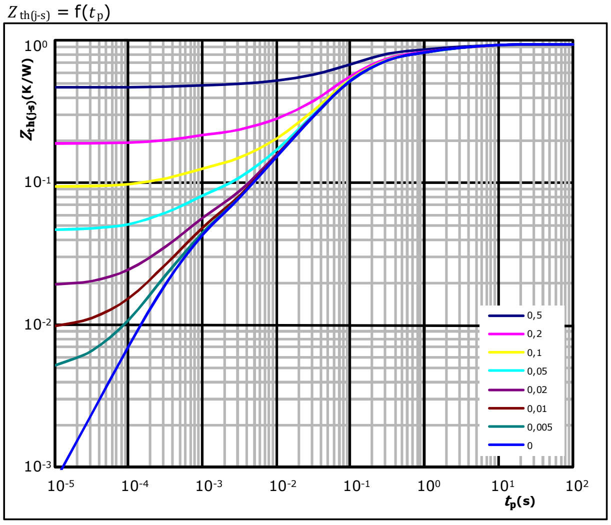


t_p = 100 μs
V_{CE} = 10 V
T_j: 25 °C, 125 °C, 150 °C

figure 4. **IGBT**

Transient thermal impedance as function of pulse duration

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$
$R_{th(j-s)}$ = 0,94 K/W

IGBT thermal model values

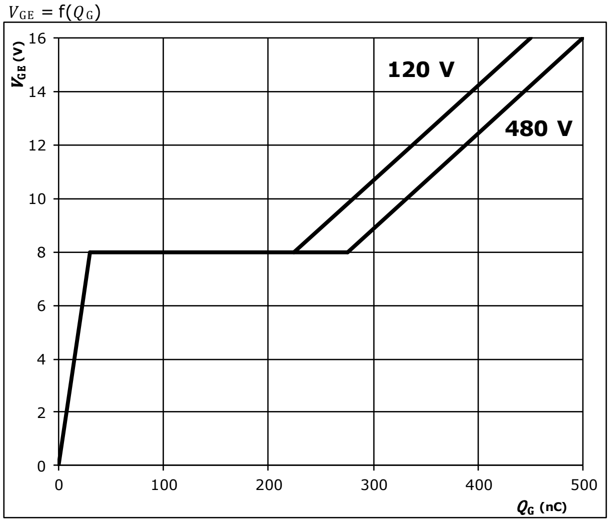
R (K/W)	τ (s)
8,02E-02	4,50E+00
1,26E-01	1,07E+00
3,43E-01	1,53E-01
2,97E-01	5,33E-02
6,50E-02	7,48E-03
3,26E-02	5,38E-04

Boost Switch Characteristics

figure 5. IGBT

Gate voltage vs gate charge

$V_{GE} = f(Q_G)$

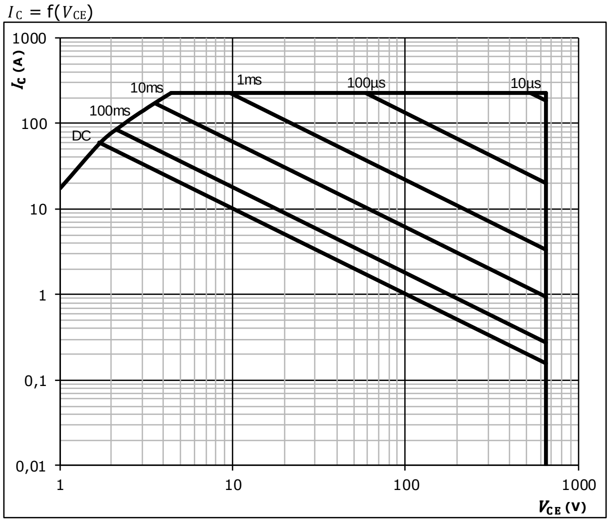


$I_C =$ 75 A

figure 6. IGBT

Safe operating area

$I_C = f(V_{CE})$

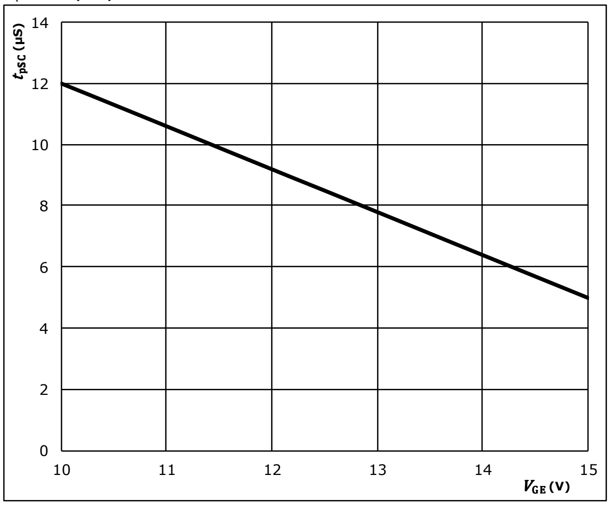


D =	single pulse	
T_s =	80	ºC
V_{GE} =	±15	V
T_j =	T_{jmax}	ºC

figure 7. IGBT

Short circuit duration as a function of V_{GE}

$t_{pSC} = f(V_{GE})$

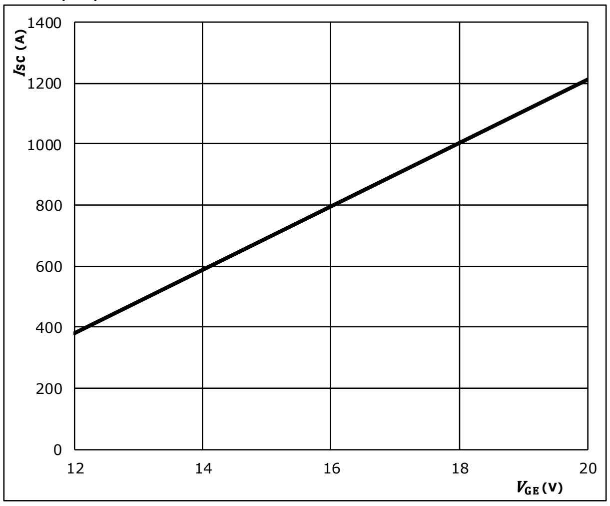


V_{CE} =	400	V
T_j ≤	150	ºC

figure 8. IGBT

Typical short circuit current as a function of V_{GE}

$I_{SC} = f(V_{GE})$



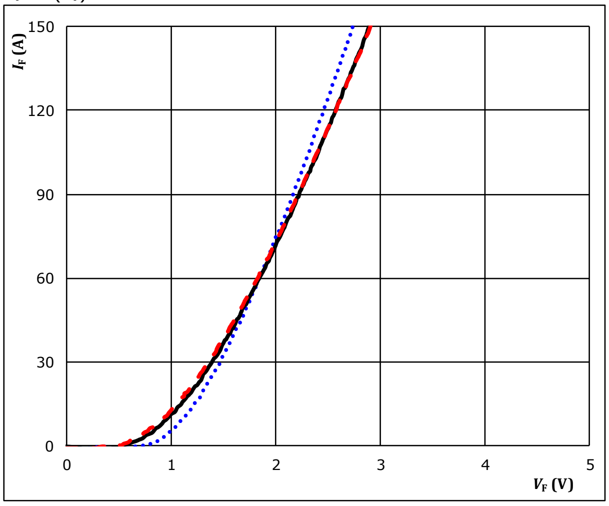
V_{CE} ≤	400	V
T_j ≤	150	ºC

Boost Diode Characteristics

figure 1. **FWD**

Typical forward characteristics

$I_F = f(V_F)$



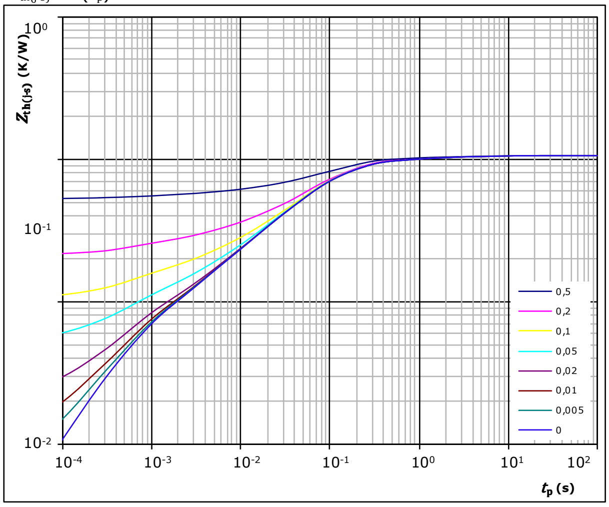
t_p = 250 µs

T_j: 25 °C, 125 °C, 150 °C

figure 2. **FWD**

Transient thermal impedance as a function of pulse width

$Z_{th(j-s)} = f(t_p)$



$D = t_p / T$

$R_{th(j-s)}$ = 1,06 K/W

FWD thermal model values

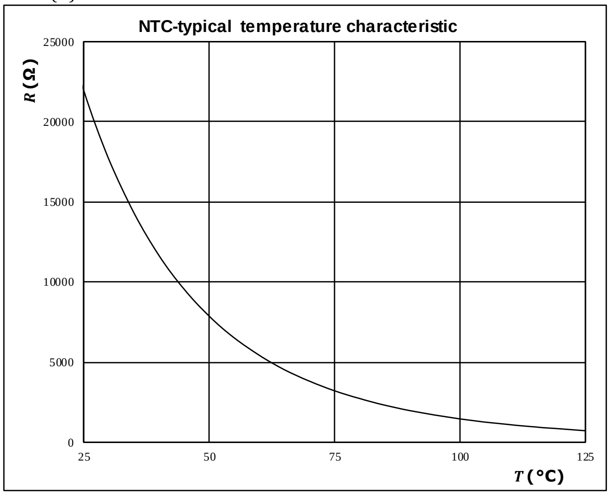
R (K/W)	τ (s)
4,19E-02	4,68E+00
8,50E-02	8,80E-01
4,99E-01	1,21E-01
2,83E-01	4,12E-02
9,28E-02	6,53E-03
5,92E-02	6,76E-04

Thermistor Characteristics

figure 1. **Thermistor**

Typical NTC characteristic
as a function of temperature

$R = f(T)$

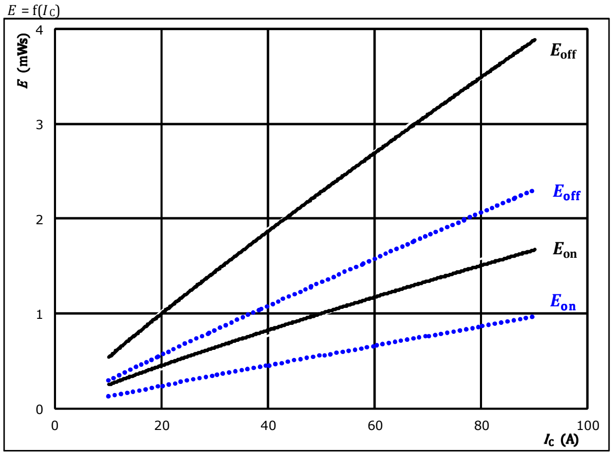


Buck Switching Characteristics

figure 1. **IGBT**

Typical switching energy losses as a function of collector current

$E = f(I_C)$



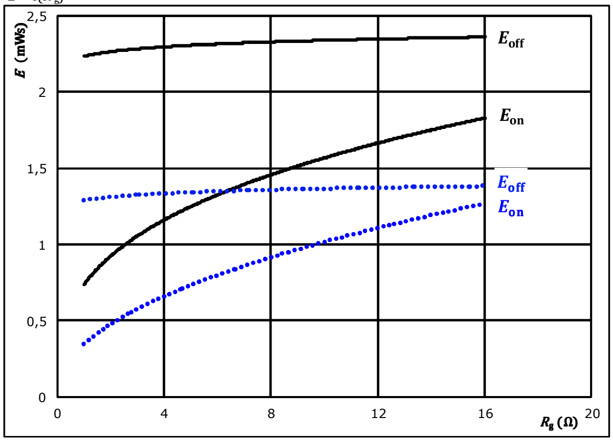
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
R_{gon} =	4	Ω		
R_{goff} =	4	Ω		

figure 2. **IGBT**

Typical switching energy losses as a function of gate resistor

$E = f(R_g)$



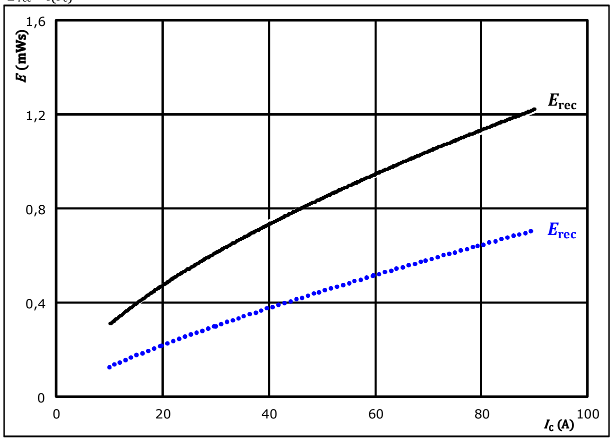
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
I_C =	50	A		

figure 3. **FWD**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



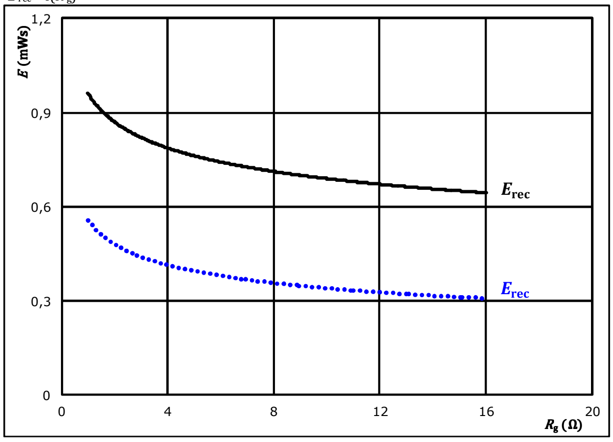
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
R_{gon} =	4	Ω		

figure 4. **FWD**

Typical reverse recovered energy loss as a function of gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

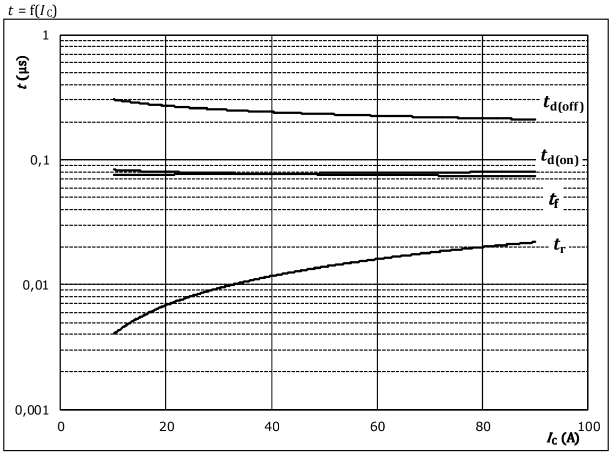
V_{CE} =	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
I_C =	50	A		

Buck Switching Characteristics

figure 5. **IGBT**

Typical switching times as a function of collector current

$t = f(I_C)$



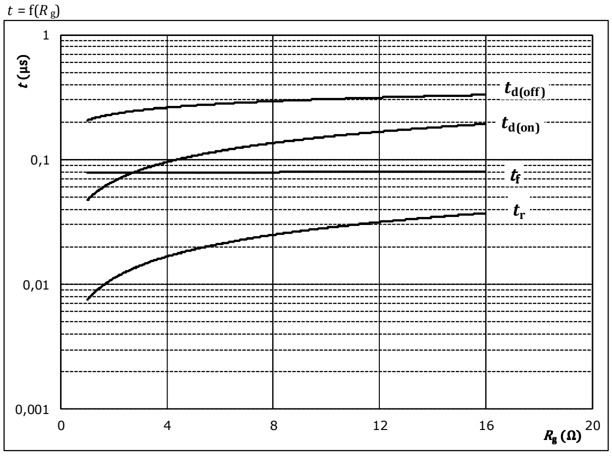
With an inductive load at

T_j =	0	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

figure 6. **IGBT**

Typical switching times as a function of gate resistor

$t = f(R_g)$



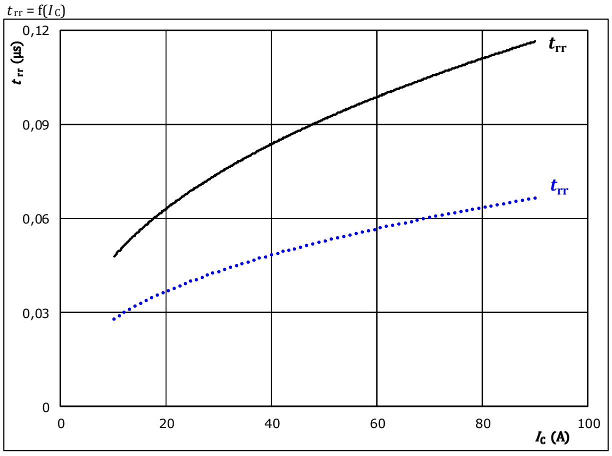
With an inductive load at

T_j =	0	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	50	A

figure 7. **FWD**

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$



With an inductive load at

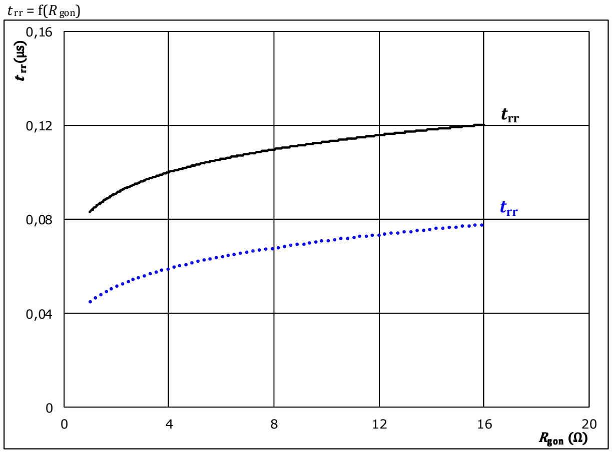
V_{CE}=	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω

T_j: 25 °C (dotted line), 125 °C (solid line)

figure 8. **FWD**

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



With an inductive load at

V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	50	A

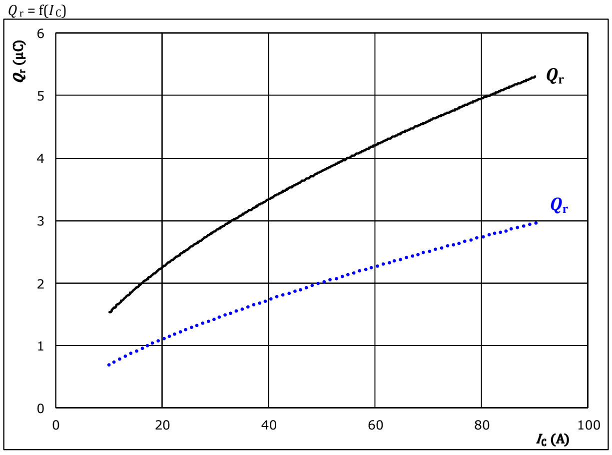
T_j: 25 °C (dotted line), 125 °C (solid line)

Buck Switching Characteristics

figure 9. **FWD**

Typical recovered charge as a function of collector current

$Q_r = f(I_C)$



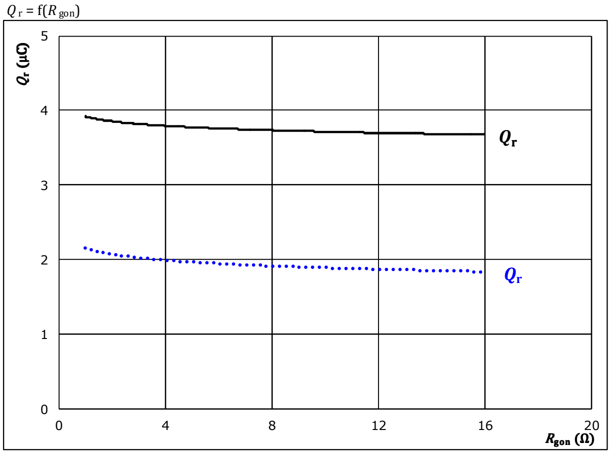
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
R_{gon} =	4	Ω		

figure 10. **FWD**

Typical recovered charge as a function of IGBT turn on gate resistor

$Q_r = f(R_{gon})$



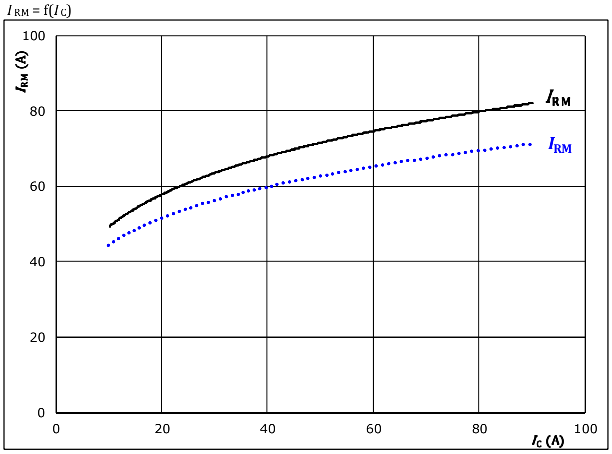
With an inductive load at

V_{CE}=	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
I_C=	50	A		

figure 11. **FWD**

Typical peak reverse recovery current current as a function of collector current

$I_{RM} = f(I_C)$



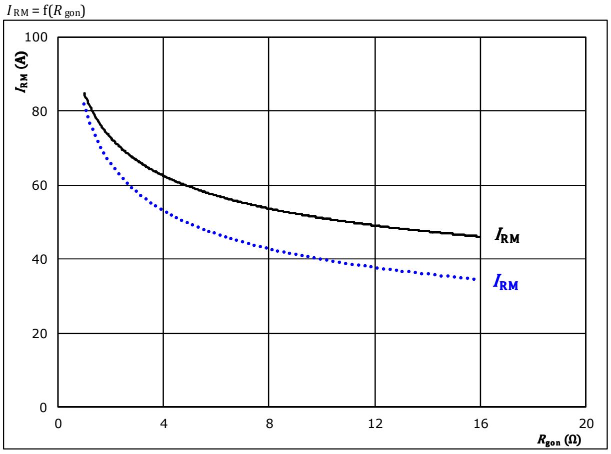
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
R_{gon} =	4	Ω		

figure 12. **FWD**

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$I_{RM} = f(R_{gon})$



With an inductive load at

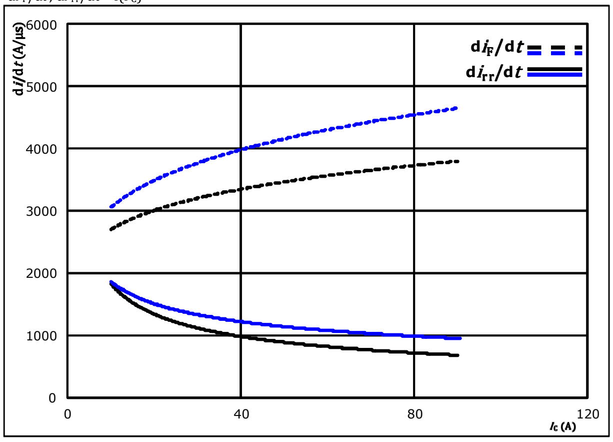
V_{CE} =	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
I_C =	50	A		

Buck Switching Characteristics

figure 13. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, $di_{rr}/dt = f(I_C)$



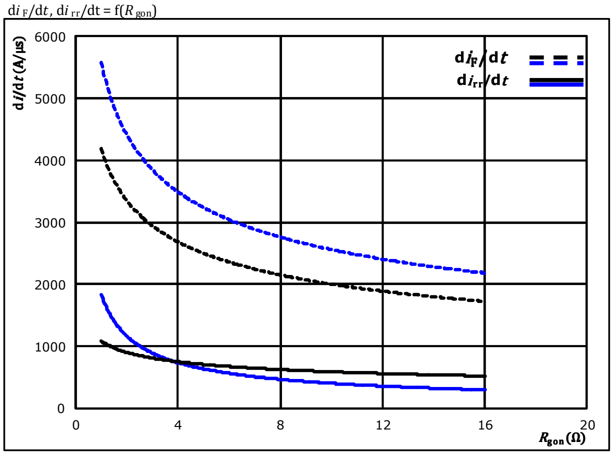
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	4	Ω		

figure 14. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

di_F/dt, $di_{rr}/dt = f(R_{gon})$



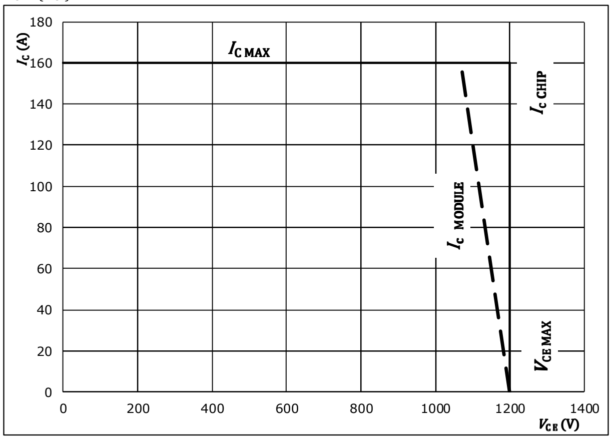
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C=	50	A		

figure 15. **IGBT**

Reverse bias safe operating area

$I_C = f(V_{CE})$



At

T_j =	125	°C
R_{gon} =	4	Ω
R_{goff} =	4	Ω

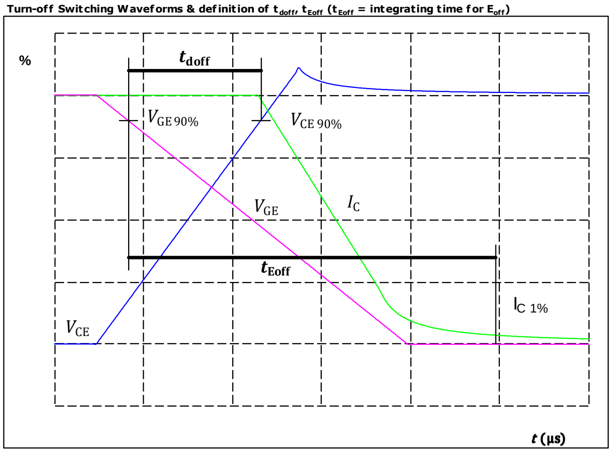
Buck Switching Definitions

General conditions

T_j	=	125 °C
R_{gon}	=	4 Ω
R_{goff}	=	4 Ω

figure 1. IGBT

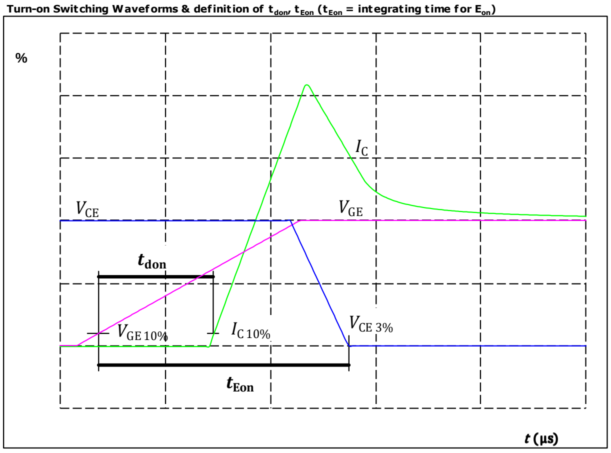
Turn-off Switching Waveforms & definition of t_{doff}, t_{Eoff} (t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%)$ =	-15	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	50	A
t_{doff} =	242	ns

figure 2. IGBT

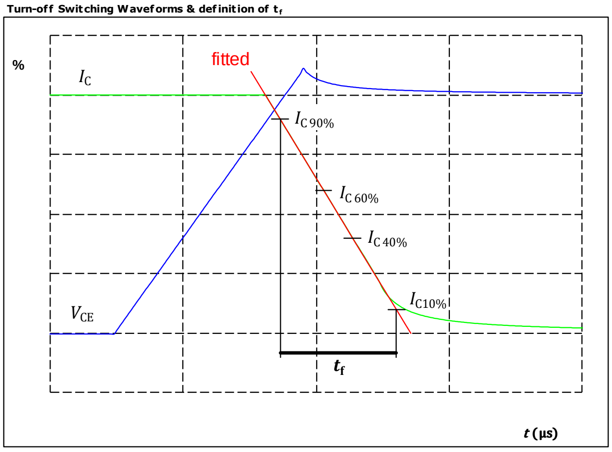
Turn-on Switching Waveforms & definition of t_{don}, t_{Eon} (t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%)$ =	-15	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	50	A
t_{don} =	79	ns

figure 3. IGBT

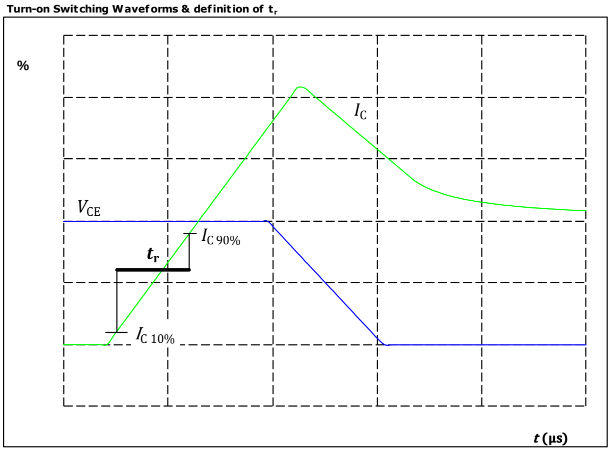
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	50	A
t_f =	76	ns

figure 4. IGBT

Turn-on Switching Waveforms & definition of t_r

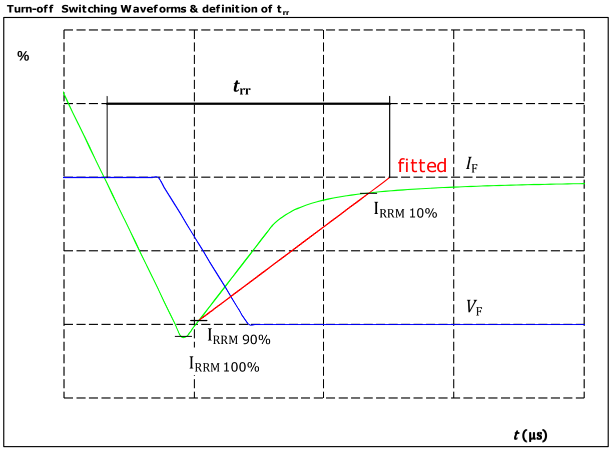


$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	50	A
t_r =	14	ns

Buck Switching Characteristics

figure 5. **FWD**

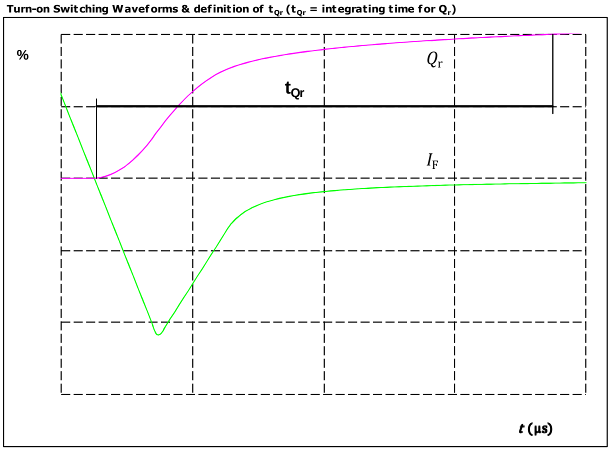
Turn-off Switching Waveforms & definition of t_{rr}



V_F (100%) =	350	V
I_F (100%) =	50	A
I_{RRM} (100%) =	73	A
t_{rr} =	92	ns

figure 6. **FWD**

Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)



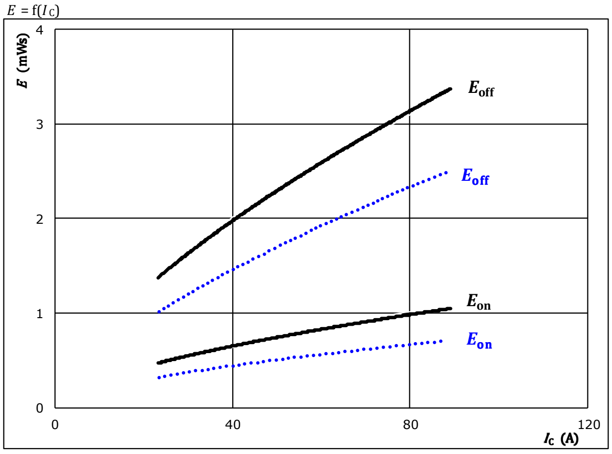
I_F (100%) =	50	A
Q_r (100%) =	3,80	µC

Boost Switching Characteristics

figure 1. **IGBT**

Typical switching energy losses as a function of collector current

$E = f(I_C)$



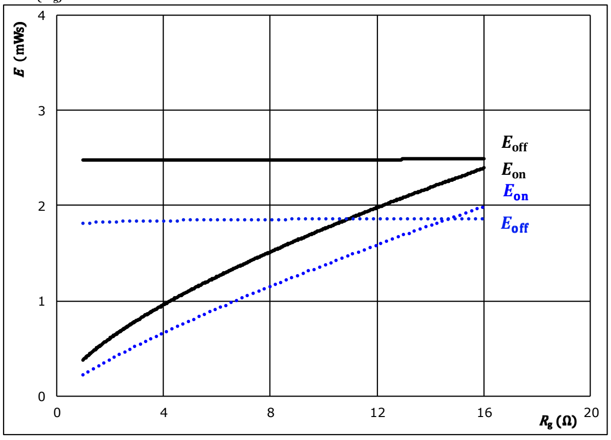
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C	dotted
V_{GE} =	±15	V		125 °C	solid
R_{gon} =	4	Ω			
R_{goff} =	4	Ω			

figure 2. **IGBT**

Typical switching energy losses as a function of gate resistor

$E = f(R_g)$



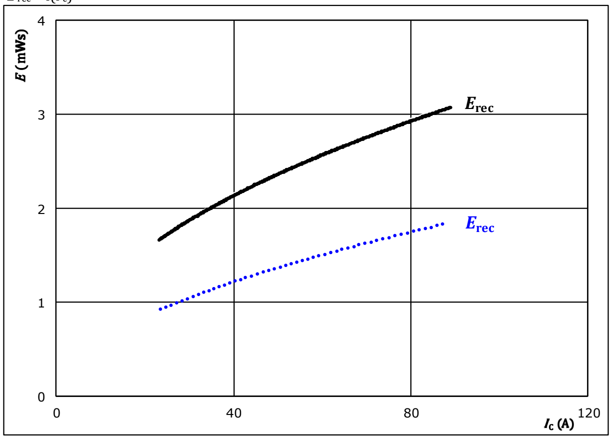
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C	dotted
V_{GE} =	±15	V		125 °C	solid
I_C =	56	A			

figure 3. **FWD**

Typical reverse recovered energy loss as a function of collector current

$E_{rec} = f(I_C)$



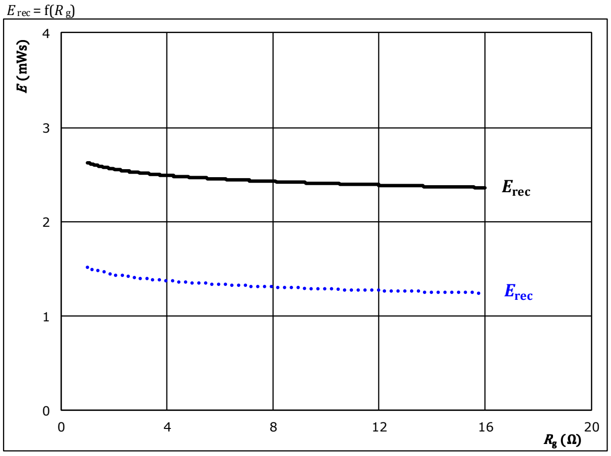
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C	dotted
V_{GE} =	±15	V		125 °C	solid
R_{gon} =	4	Ω			

figure 4. **FWD**

Typical reverse recovered energy loss as a function of gate resistor

$E_{rec} = f(R_g)$



With an inductive load at

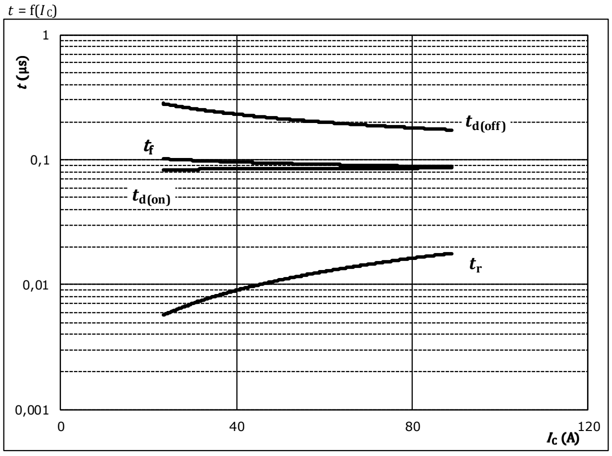
V_{CE} =	350	V	T_j:	25 °C	dotted
V_{GE} =	±15	V		125 °C	solid
I_C =	56	A			

Boost Switching Characteristics

figure 5. IGBT

Typical switching times as a function of collector current

$t = f(I_C)$



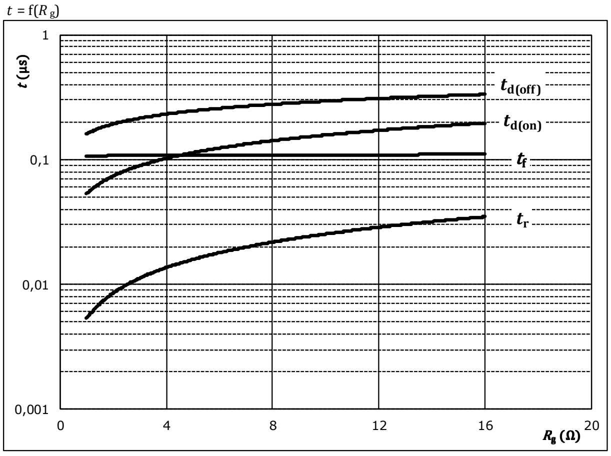
With an inductive load at

T_j =	0	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

figure 6. IGBT

Typical switching times as a function of gate resistor

$t = f(R_g)$



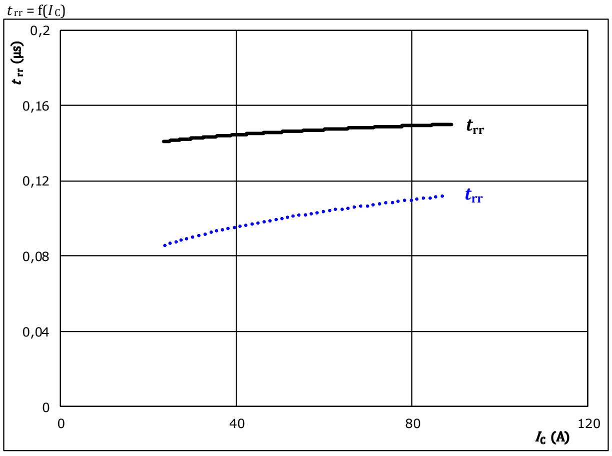
With an inductive load at

T_j =	0	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	56	A

figure 7. FWD

Typical reverse recovery time as a function of collector current

$t_{rr} = f(I_C)$



With an inductive load at

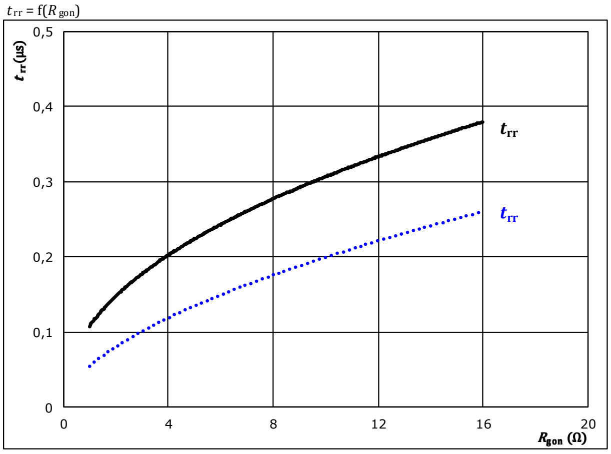
V_{CE}=	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω

T_j: 25 °C (dotted), 125 °C (solid)

figure 8. FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$t_{rr} = f(R_{gon})$



With an inductive load at

V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	56	A

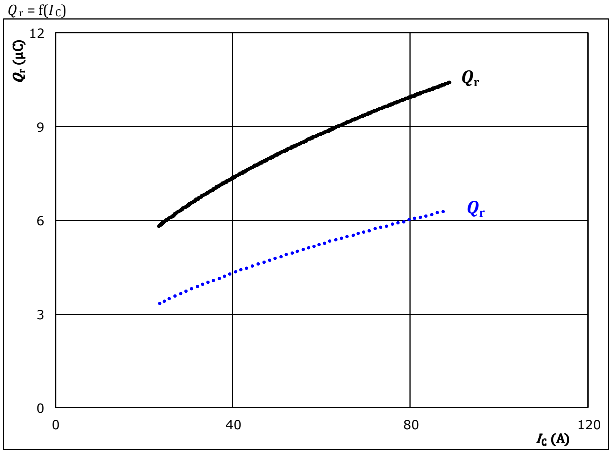
T_j: 25 °C (dotted), 125 °C (solid)

Boost Switching Characteristics

figure 9. **FWD**

Typical recovered charge as a function of collector current

$Q_r = f(I_C)$



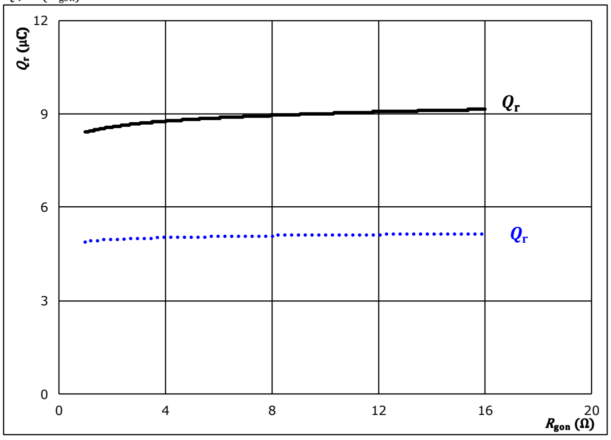
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
R_{gon} =	4	Ω		

figure 10. **FWD**

Typical recovered charge as a function of IGBT turn on gate resistor

$Q_r = f(R_{gon})$



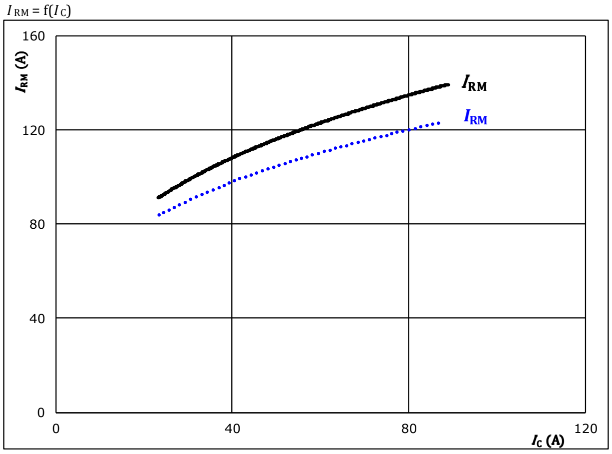
With an inductive load at

V_{CE}=	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
I_C=	56	A		

figure 11. **FWD**

Typical peak reverse recovery current current as a function of collector current

$I_{RM} = f(I_C)$



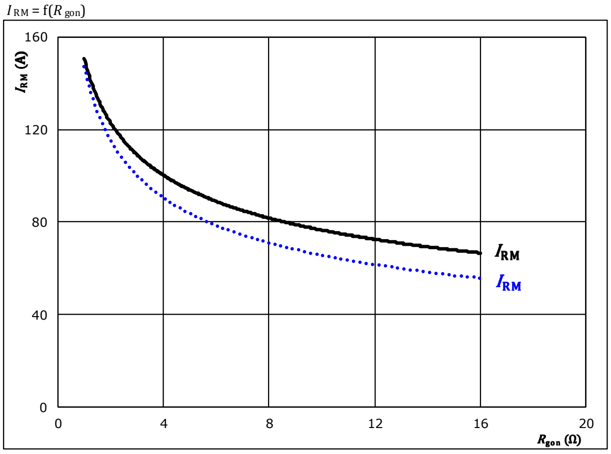
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
R_{gon} =	4	Ω		

figure 12. **FWD**

Typical peak reverse recovery current as a function of IGBT turn on gate resistor

$I_{RM} = f(R_{gon})$



With an inductive load at

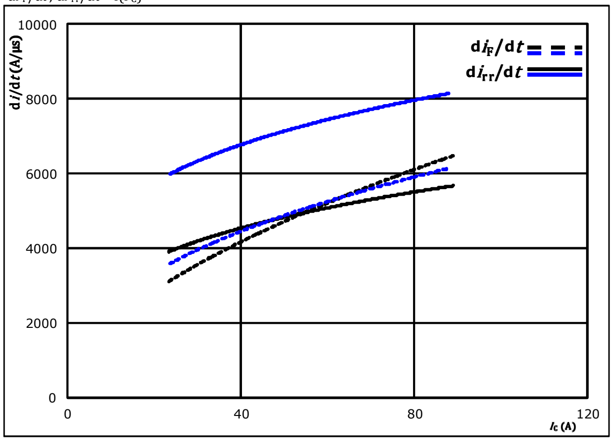
V_{CE}=	350	V	T_j:	25 °C (dotted)
V_{GE} =	±15	V		125 °C (solid)
I_C=	56	A		

Boost Switching Characteristics

figure 13. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of collector current

di_F/dt, $di_{rr}/dt = f(I_C)$



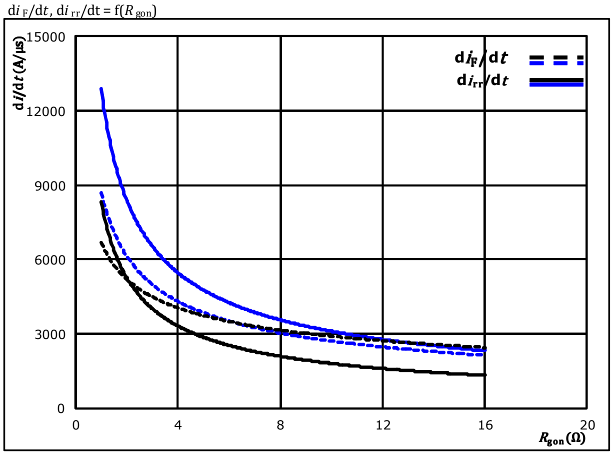
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
R_{gon} =	4	Ω		

figure 14. **FWD**

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

di_F/dt, $di_{rr}/dt = f(R_{gon})$



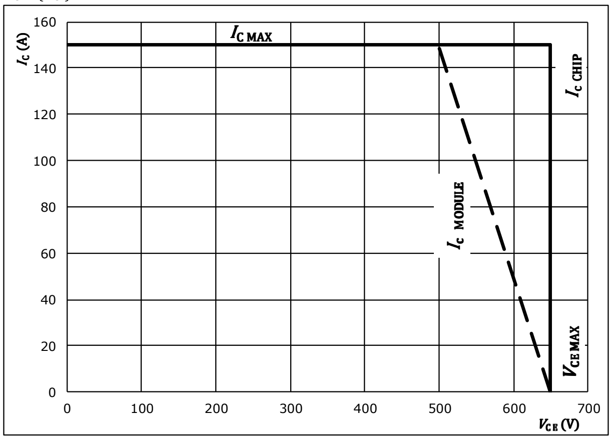
With an inductive load at

V_{CE} =	350	V	T_j:	25 °C
V_{GE} =	±15	V		125 °C
I_C =	56	A		

figure 15. **IGBT**

Reverse bias safe operating area

$I_C = f(V_{CE})$



At

T_j =	125	°C
R_{gon} =	4	Ω
R_{goff} =	4	Ω

Vincotech

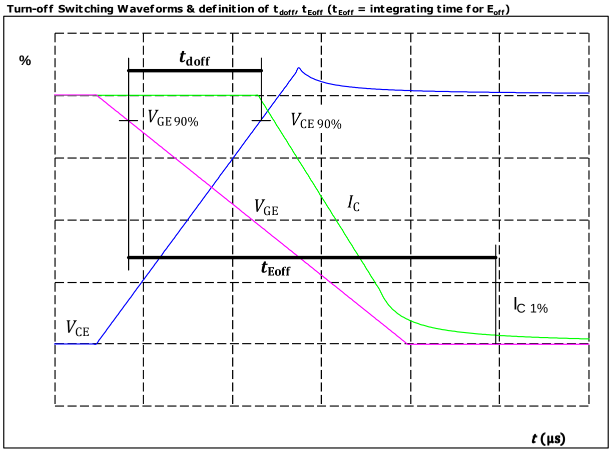
Boost Switching Definitions

General conditions

T_j	=	125 °C
R_{gon}	=	4 Ω
R_{goff}	=	4 Ω

figure 1. IGBT

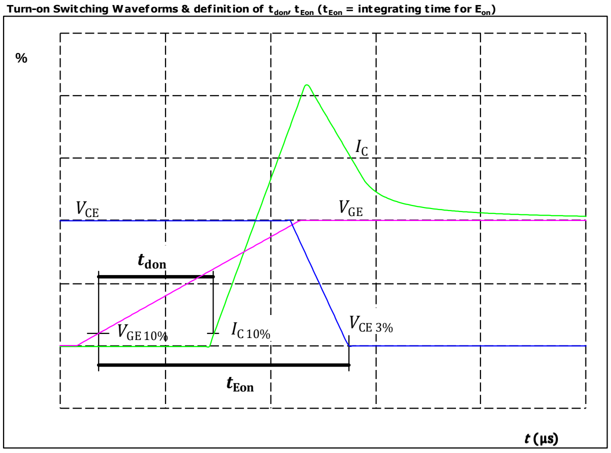
Turn-off Switching Waveforms & definition of t_{doff}, t_{Eoff} (t_{Eoff} = integrating time for E_{off})



$V_{GE}(0\%)$ =	-15	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	56	A
t_{doff} =	205	ns

figure 2. IGBT

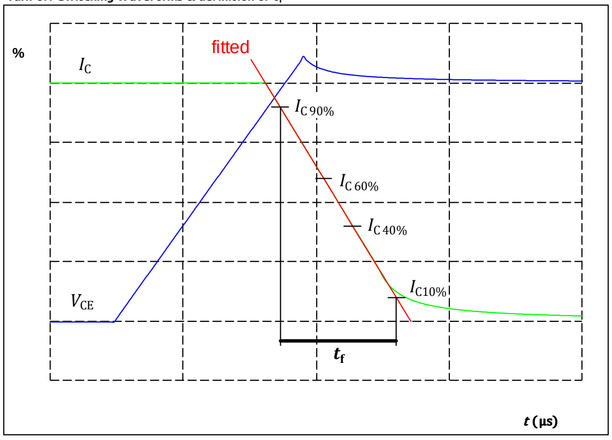
Turn-on Switching Waveforms & definition of t_{don}, t_{Eon} (t_{Eon} = integrating time for E_{on})



$V_{GE}(0\%)$ =	-15	V
$V_{GE}(100\%)$ =	15	V
$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	56	A
t_{don} =	85	ns

figure 3. IGBT

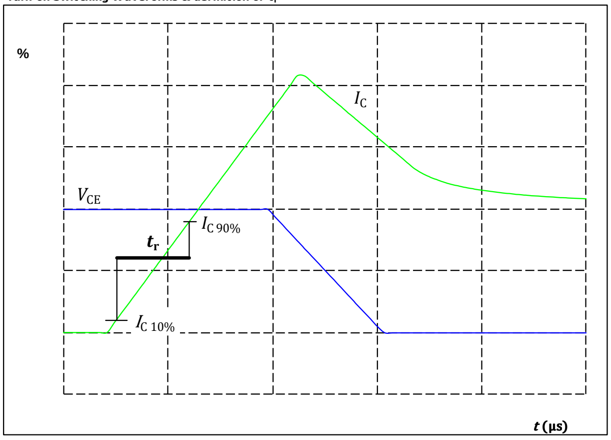
Turn-off Switching Waveforms & definition of t_f



$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	56	A
t_f =	105	ns

figure 4. IGBT

Turn-on Switching Waveforms & definition of t_r

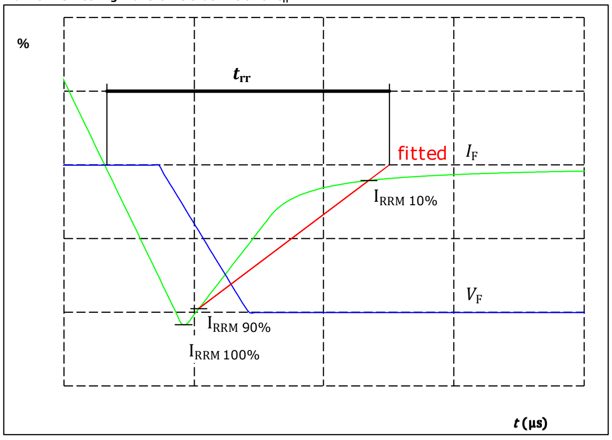


$V_C(100\%)$ =	350	V
$I_C(100\%)$ =	56	A
t_r =	12	ns

Boost Switching Characteristics

figure 5. **FWD**

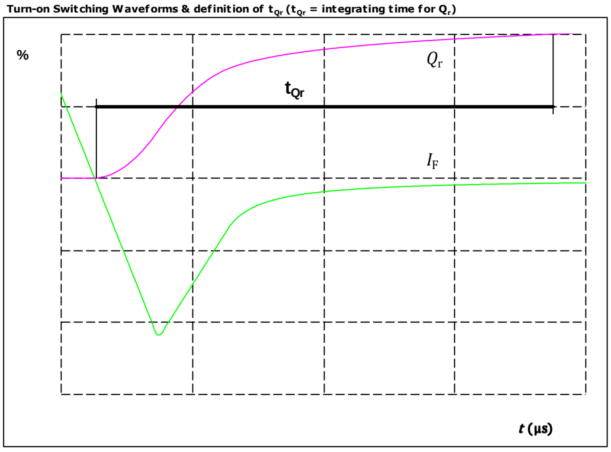
Turn-off Switching Waveforms & definition of t_{rr}



V_F (100%) =	350	V
I_F (100%) =	56	A
I_{RRM} (100%) =	118	A
t_{rr} =	148	ns

figure 6. **FWD**

Turn-on Switching Waveforms & definition of t_{Qr} (t_{Qr} = integrating time for Q_r)



I_F (100%) =	56	A
Q_r (100%) =	8,22	µC

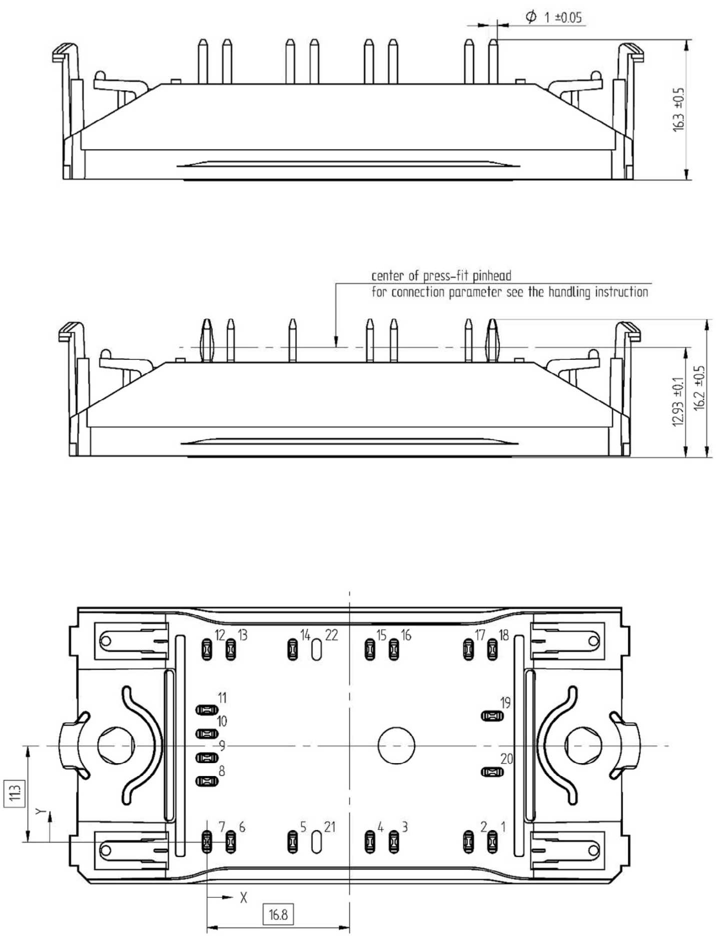
Ordering Code & Marking

Version	Ordering Code
without thermal paste 12mm housing with solder pins	10-FZ12NMA080SH04-M260F13
without thermal paste 12mm housing with Press-fit pins	10-PZ12NMA080SH04-M260F13Y

	Name		Date code	UL & VIN	Lot	Serial
Text	NN-NNNNNNNNNNNNNN-TTTTTTVV		WWYY	UL VIN	LLLLL	SSSS
Datamatrix	Type&Ver	Lot number	Serial	Date code		
	TTTTTTTVV	LLLLL	SSSS	WWYY		

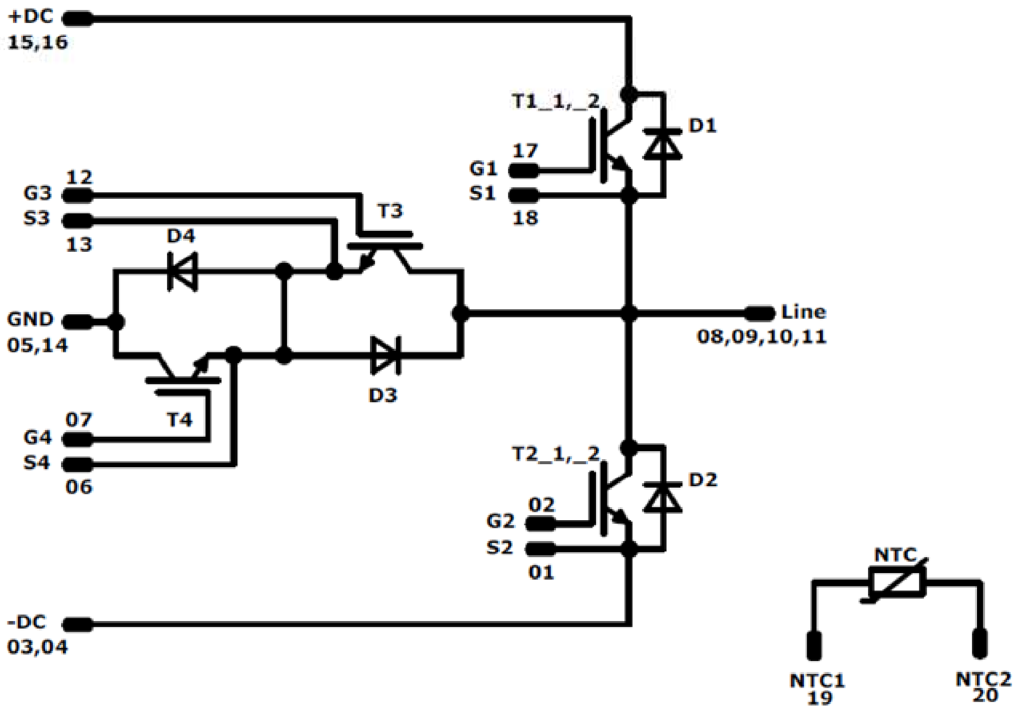
Outline

Pin table			
Pin	X	Y	Function
1	33,6	0	S2
2	30,8	0	G2
3	22	0	-DC
4	19,2	0	-DC
5	10,1	0	GND
6	2,8	0	S4
7	0	0	G4
8	0	7,1	Line
9	0	9,9	Line
10	0	12,7	Line
11	0	15,5	Line
12	0	22,6	G3
13	2,8	22,6	S3
14	10,1	22,6	GND
15	19,2	22,6	+DC
16	22	22,6	+DC
17	30,8	22,6	G1
18	33,6	22,6	S1
19	33,6	14,8	NTC1
20	33,6	8,2	NTC2
21	Not assembled		
22	Not assembled		



Tolerance of pinpositions: ±0.5mm at the end of pins
Dimension of coordinate axis is only offset without tolerance

Pinout



Identification

ID	Component	Voltage	Current	Function	Comment
T1, T2	IGBT	1200 V	80 A	Buck Switch	
D3, D4	FWD	650 V	75 A	Buck Diode	
T3, T4	IGBT	650 V	75 A	Boost Switch	
D1, D2	FWD	1200 V	50 A	Boost Diode	
NTC	NTC			Thermistor	

Packaging instruction				
Standard packaging quantity (SPQ) 135	>SPQ	Standard	<SPQ	Sample

Handling instruction
Handling instructions for *flow* 0 packages see vincotech.com website.

Package data
Package data for *flow* 0 packages see vincotech.com website.

UL recognition and file number
This device is certified according to UL 1557 standard, UL file number E192116. For more information see vincotech.com website.

Document No.:	Date:	Modification:	Pages
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